

Notice of References Cited

Application/Control No.

10/539,787

Applicant(s)/Patent Under
Reexamination
ABERG ET AL.

Examiner

COURTNEY D. FIELDS

Art Unit

2437

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U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY		
*	A	US-2002/0086706	07-2002	Chen et al.	455/560
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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